## Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10553095	AOKI ET AL.
Examiner	Art Unit
Wayne K Leung	4171

SEA	RCH	HED
-----	-----	-----

Class	Subclass	Date	Examiner
524	500	7/01/2008	/wkl/
106	287.11	12/16/2008	/DDL/
257	760	12/16/2008	/DDL/
427	126.2, 226, 340, 372.2, 373, 387, 397.7	12/16/2008	/DDL/
428	446, 701, 702	12/16/2008	/DDL/
438	637	12/16/2008	/DDL/
501	92, 96, 97, 98	12/16/2008	/DDL/
524	115, 122, 127, 236, 500, 858, 869, 588	12/16/2008	/DDL/
525	25, 26, 275, 28 38, 474, 475, 477	12/16/2008	/DDL/
528	14, 15, 18, 28, 29, 31, 33, 34, 38, 486, 490, 499, 503	12/16/2008	/DDL/
556	412, 413	12/16/2008	/DDL/

$\sim$ $\sim$	$\Delta$	$\sim$ 11		TES
> E	$\Delta \kappa$	ı.H	NI.	

Search Notes	Date	Examiner
Inventor Search	7/01/2008	/wkl/
ISR search	7/01/2008	/wkl/
EAST search	7/01/2008	/wkl/
discussion with Walter Choi	7/01/2008	/wkl/
Updated inventor search	12/16/2008	/DDL/
Updated EAST search	12/16/2008	/DDL/
Review of case materials	12/16/2008	/DDL/
Search of Japanese patent literature	12/16/2008	/DDL/

	INTERFERENCE SEARCH		
Class	Subclass	Date	Examiner

U.S. Patent and Trademark Office Part of Paper No.: 20081215